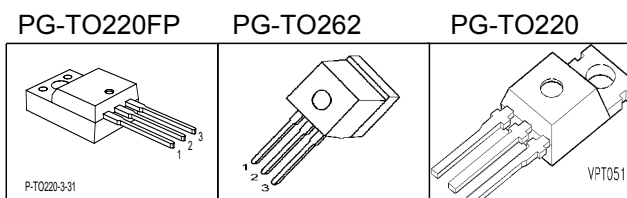


## Cool MOS™ Power Transistor

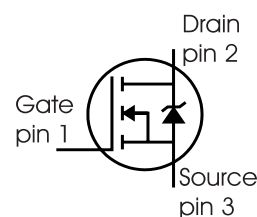
### Feature

- New revolutionary high voltage technology
- Ultra low gate charge
- Periodic avalanche rated
- Extreme  $dv/dt$  rated
- Ultra low effective capacitances
- Improved transconductance
- PG-TO-220-3-31;-3-111: Fully isolated package (2500 VAC; 1 minute)
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>0)</sup> for target applications

|                     |      |          |
|---------------------|------|----------|
| $V_{DS} @ T_{jmax}$ | 650  | V        |
| $R_{DS(on)}$        | 0.28 | $\Omega$ |
| $I_D$               | 15   | A        |



| Type       | Package    | Ordering Code | Marking |
|------------|------------|---------------|---------|
| SPP15N60C3 | PG-TO220   | Q67040-S4600  | 15N60C3 |
| SPI15N60C3 | PG-TO262   | Q67040-S4601  | 15N60C3 |
| SPA15N60C3 | PG-TO220FP | SP000216325   | 15N60C3 |



### Maximum Ratings

| Parameter  | Symbol              | Value      |                                       | Unit        |
|--|---------------------|------------|---------------------------------------|-------------|
|  |                     | SPP_I      | SPA                                   |             |
| Continuous drain current<br>$T_C = 25\text{ °C}$<br>$T_C = 100\text{ °C}$  | $I_D$               | 15<br>9.4  | 15 <sup>1)</sup><br>9.4 <sup>1)</sup> | A           |
| Pulsed drain current, $t_p$ limited by $T_{jmax}$  | $I_{D\text{ puls}}$ | 45         | 45                                    | A           |
| Avalanche energy, single pulse<br>$I_D=7.5\text{A}, V_{DD}=50\text{V}$   | $E_{AS}$            | 460        | 460                                   | mJ          |
| Avalanche energy, repetitive $t_{AR}$ limited by $T_{jmax}$ <sup>2)</sup><br>$I_D=15\text{A}, V_{DD}=50\text{V}$ | $E_{AR}$            | 0.8        | 0.8                                   |             |
| Avalanche current, repetitive $t_{AR}$ limited by $T_{jmax}$   | $I_{AR}$            | 15         | 15                                    | A           |
| Gate source voltage static   | $V_{GS}$            | $\pm 20$   | $\pm 20$                              | V           |
| Gate source voltage AC ( $f > 1\text{Hz}$ )  | $V_{GS}$            | $\pm 30$   | $\pm 30$                              |             |
| Power dissipation, $T_C = 25\text{ °C}$  | $P_{tot}$           | 156        | 34                                    | W           |
| Operating and storage temperature  | $T_j, T_{stg}$      | -55...+150 |                                       | $\text{°C}$ |
| Reverse diode $dv/dt$ <sup>6)</sup>  | $dv/dt$             | 15         |                                       | V/ns        |

**Maximum Ratings**

| Parameter   | Symbol  | Value | Unit |
|---|---------|-------|------|
| Drain Source voltage slope<br>$V_{DS} = 480\text{ V}$ , $I_D = 15\text{ A}$ , $T_j = 125\text{ °C}$ | $dv/dt$ | 50    | V/ns |

**Thermal Characteristics**

| Parameter   | Symbol               | Values |      |      | Unit |
|---|----------------------|--------|------|------|------|
|   |                      | min.   | typ. | max. |      |
| Thermal resistance, junction - case   | $R_{thJC}$           | -      | -    | 0.8  | K/W  |
| Thermal resistance, junction - case, FullPAK  | $R_{thJC\text{ FP}}$ | -      | -    | 3.7  |      |
| Thermal resistance, junction - ambient, leaded  | $R_{thJA}$           | -      | -    | 62   |      |
| Thermal resistance, junction - ambient, FullPAK   | $R_{thJA\text{ FP}}$ | -      | -    | 80   |      |
| Soldering temperature, wavesoldering<br>1.6 mm (0.063 in.) from case for 10s <sup>3</sup> ) | $T_{sold}$           | -      | -    | 260  | °C   |

**Electrical Characteristics, at  $T_j=25\text{ °C}$  unless otherwise specified**

| Parameter                                   | Symbol        | Conditions   | Values |      |      | Unit          |
|---|---------------|--|--------|------|------|---------------|
|   |               |  | min.   | typ. | max. |               |
| Drain-source breakdown voltage              | $V_{(BR)DSS}$ | $V_{GS}=0\text{V}$ , $I_D=0.25\text{mA}$   | 600    | -    | -    | V             |
| Drain-Source avalanche<br>breakdown voltage | $V_{(BR)DS}$  | $V_{GS}=0\text{V}$ , $I_D=15\text{A}$  | -      | 700  | -    |               |
| Gate threshold voltage                      | $V_{GS(th)}$  | $I_D=675\mu\text{A}$ , $V_{GS}=V_{DS}$   | 2.1    | 3    | 3.9  |               |
| Zero gate voltage drain current             | $I_{DSS}$     | $V_{DS}=600\text{V}$ , $V_{GS}=0\text{V}$ ,<br>$T_j=25\text{ °C}$<br>$T_j=150\text{ °C}$ | -      | 0.1  | 1    | $\mu\text{A}$ |
| Gate-source leakage current                 | $I_{GSS}$     | $V_{GS}=30\text{V}$ , $V_{DS}=0\text{V}$   | -      | -    | 100  |               |
| Drain-source on-state resistance            | $R_{DS(on)}$  | $V_{GS}=10\text{V}$ , $I_D=9.4\text{A}$<br>$T_j=25\text{ °C}$<br>$T_j=150\text{ °C}$     | -      | 0.25 | 0.28 | $\Omega$      |
| Gate input resistance                       | $R_G$         | $f=1\text{MHz}$ , open drain   | -      | 1.23 | -    |               |

**Electrical Characteristics**

| Parameter   | Symbol       | Conditions  | Values |      |      | Unit |
|---|--------------|---|--------|------|------|------|
|   |              |   | min.   | typ. | max. |      |
| Transconductance  | $g_{fs}$     | $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ ,<br>$I_D = 9.4A$ | -      | 11.9 | -    | S    |
| Input capacitance   | $C_{iss}$    | $V_{GS} = 0V$ , $V_{DS} = 25V$ ,                                | -      | 1660 | -    | pF   |
| Output capacitance  | $C_{oss}$    | $f = 1MHz$  | -      | 540  | -    |      |
| Reverse transfer capacitance                                  | $C_{rss}$    |   | -      | 40   | -    |      |
| Effective output capacitance, <sup>4)</sup><br>energy related | $C_{o(er)}$  | $V_{GS} = 0V$ ,<br>$V_{DS} = 0V$ to 480V                        | -      | 80   | -    |      |
| Effective output capacitance, <sup>5)</sup><br>time related   | $C_{o(tr)}$  |   | -      | 127  | -    |      |
| Turn-on delay time  | $t_{d(on)}$  | $V_{DD} = 480V$ , $V_{GS} = 0/10V$ ,                            | -      | 10   | -    | ns   |
| Rise time   | $t_r$        | $I_D = 15A$ ,   | -      | 5    | -    |      |
| Turn-off delay time   | $t_{d(off)}$ | $R_G = 4.3\Omega$   | -      | 50   | 80   |      |
| Fall time   | $t_f$        |   | -      | 5    | 10   |      |

**Gate Charge Characteristics**

|                       |                 |  |   |    |   |    |
|-----------------------|-----------------|--|---|----|---|----|
| Gate to source charge | $Q_{gs}$        | $V_{DD} = 480V$ , $I_D = 15A$                          | - | 7  | - | nC |
| Gate to drain charge  | $Q_{gd}$        |  | - | 29 | - |    |
| Gate charge total     | $Q_g$           | $V_{DD} = 480V$ , $I_D = 15A$ ,<br>$V_{GS} = 0$ to 10V | - | 63 | - |    |
| Gate plateau voltage  | $V_{(plateau)}$ | $V_{DD} = 480V$ , $I_D = 15A$                          | - | 5  | - | V  |

<sup>0</sup>J-STD20 and JESD22

<sup>1</sup>Limited only by maximum temperature

<sup>2</sup>Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV} = E_{AR} \cdot f$ .

<sup>3</sup>Soldering temperature for TO-263: 220°C, reflow

<sup>4</sup> $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>5</sup> $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>6</sup> $I_{SD} \leq I_D$ ,  $di/dt \leq 400A/\mu s$ ,  $V_{DClk} = 400V$ ,  $V_{peak} < V_{BR, DSS}$ ,  $T_j < T_{j,max}$ .

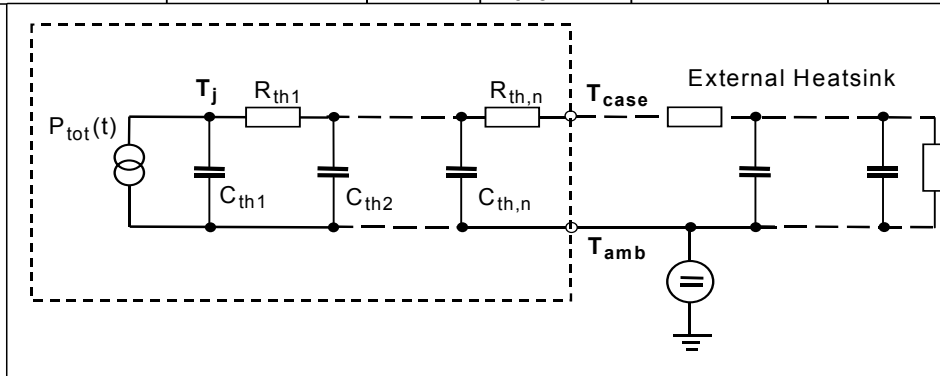
Identical low-side and high-side switch.

**Electrical Characteristics**

| Parameter                                     | Symbol       | Conditions                        | Values |      |      | Unit                   |
|---|--------------|-----------------------------------|--------|------|------|------------------------|
|   |              |                                   | min.   | typ. | max. |                        |
| Inverse diode continuous forward current      | $I_S$        | $T_C=25^\circ\text{C}$            | -      | -    | 15   | A                      |
| Inverse diode direct current, pulsed          | $I_{SM}$     |                                   | -      | -    | 45   |                        |
| Inverse diode forward voltage                 | $V_{SD}$     | $V_{GS}=0\text{V}, I_F=I_S$       | -      | 1    | 1.2  | V                      |
| Reverse recovery time                         | $t_{rr}$     | $V_R=480\text{V}, I_F=I_S,$       | -      | 460  | -    | ns                     |
| Reverse recovery charge                       | $Q_{rr}$     | $di_F/dt=100\text{A}/\mu\text{s}$ | -      | 27   | -    | $\mu\text{C}$          |
| Peak reverse recovery current                 | $I_{rrm}$    |                                   | -      | 55   | -    | A                      |
| Peak rate of fall of reverse recovery current | $di_{rr}/dt$ | $T_j=25^\circ\text{C}$            | -      | 1300 | -    | $\text{A}/\mu\text{s}$ |

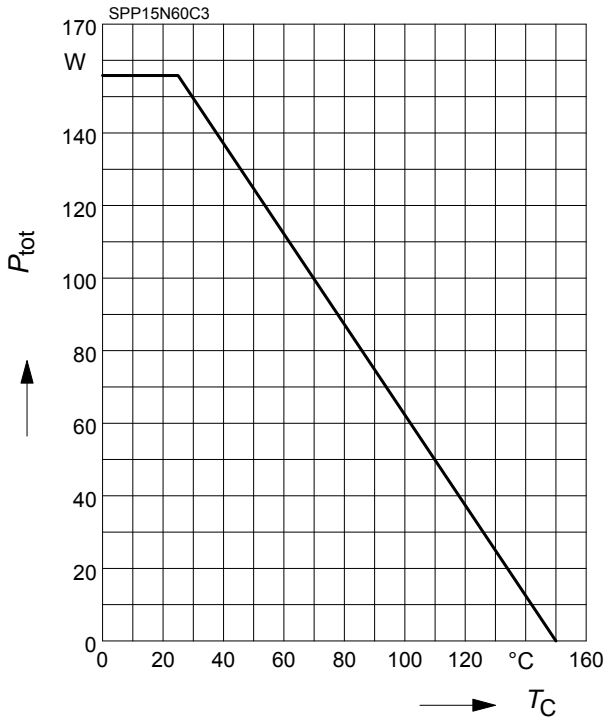
**Typical Transient Thermal Characteristics**

| Symbol    | Value |       | Unit | Symbol    | Value     |           | Unit |
|-----------|-------|-------|------|-----------|-----------|-----------|------|
|           | SPP_I | SPA   |      |           | SPP_I     | SPA       |      |
| $R_{th1}$ | 0.012 | 0.012 | K/W  | $C_{th1}$ | 0.0002495 | 0.0002495 | Ws/K |
| $R_{th2}$ | 0.023 | 0.023 |      | $C_{th2}$ | 0.0009406 | 0.0009406 |      |
| $R_{th3}$ | 0.043 | 0.043 |      | $C_{th3}$ | 0.001298  | 0.001298  |      |
| $R_{th4}$ | 0.156 | 0.176 |      | $C_{th4}$ | 0.00362   | 0.00362   |      |
| $R_{th5}$ | 0.178 | 0.371 |      | $C_{th5}$ | 0.009046  | 0.008025  |      |
| $R_{th6}$ | 0.072 | 2.522 |      | $C_{th6}$ | 0.412     | 0.412     |      |



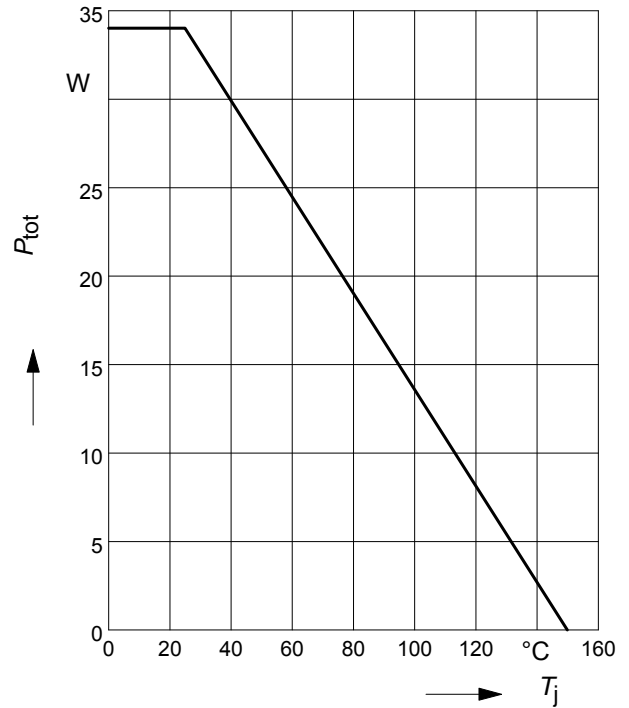
**1 Power dissipation**

$P_{tot} = f(T_C)$



**2 Power dissipation FullPAK**

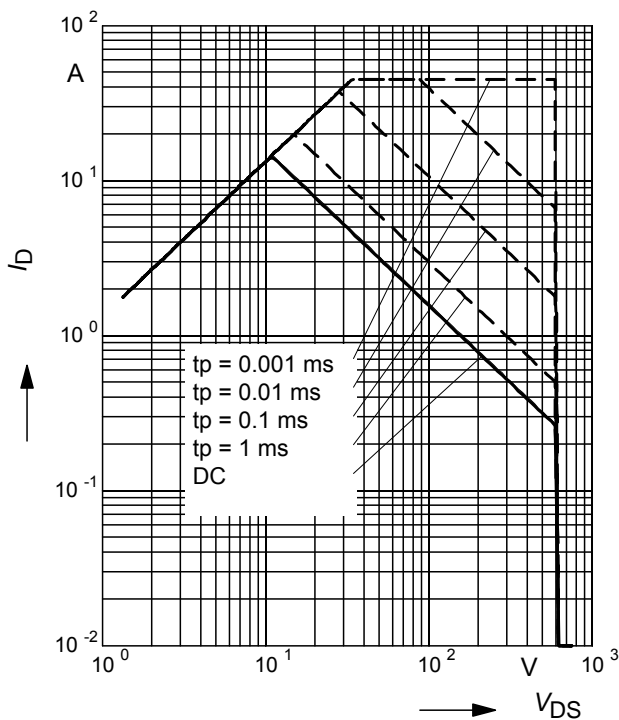
$P_{tot} = f(T_j)$



**3 Safe operating area**

$I_D = f(V_{DS})$

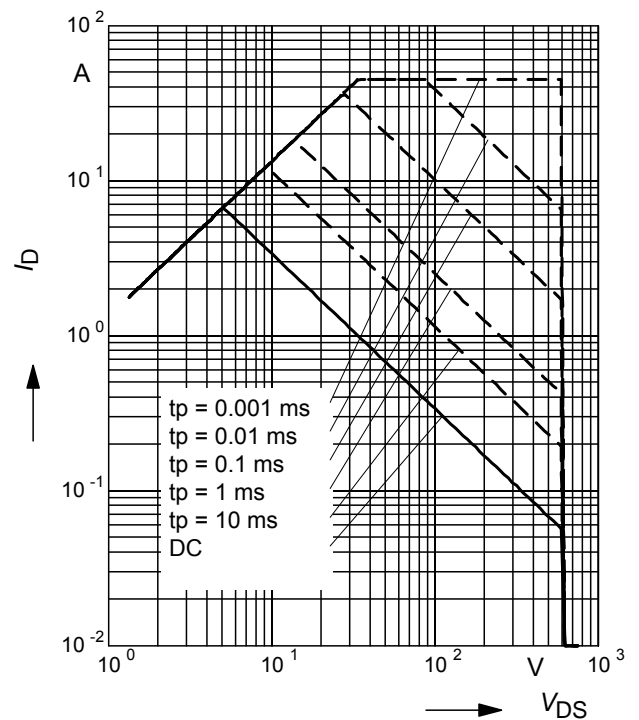
parameter :  $D = 0$  ,  $T_C = 25^\circ\text{C}$



**4 Safe operating area FullPAK**

$I_D = f(V_{DS})$

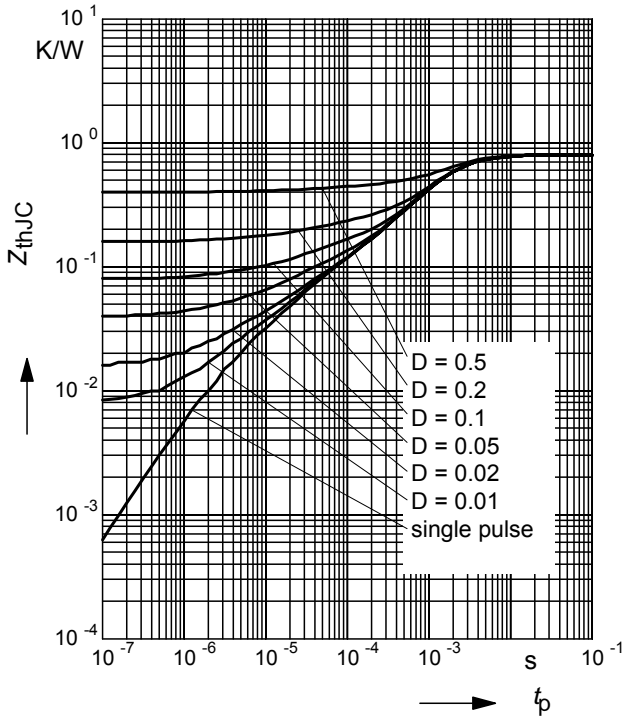
parameter:  $D = 0$  ,  $T_C = 25^\circ\text{C}$



### 5 Transient thermal impedance

$$Z_{thJC} = f(t_p)$$

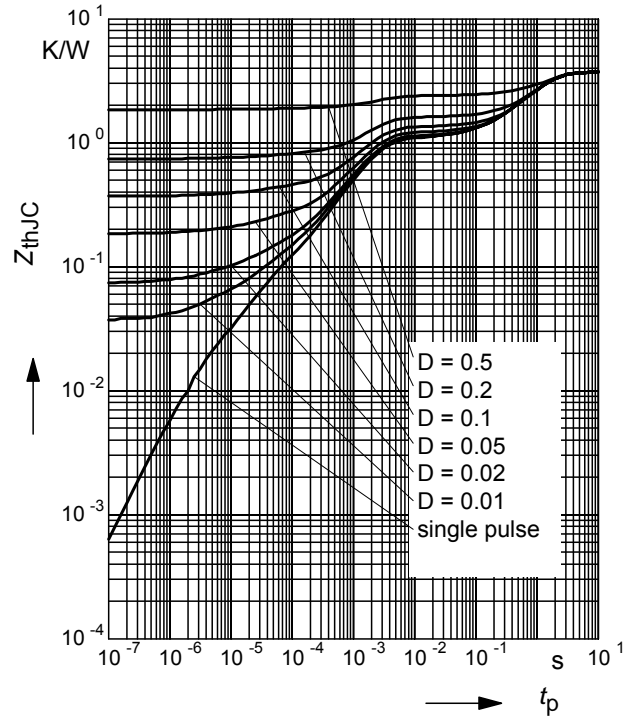
parameter:  $D = t_p/T$



### 6 Transient thermal impedance FullPAK

$$Z_{thJC} = f(t_p)$$

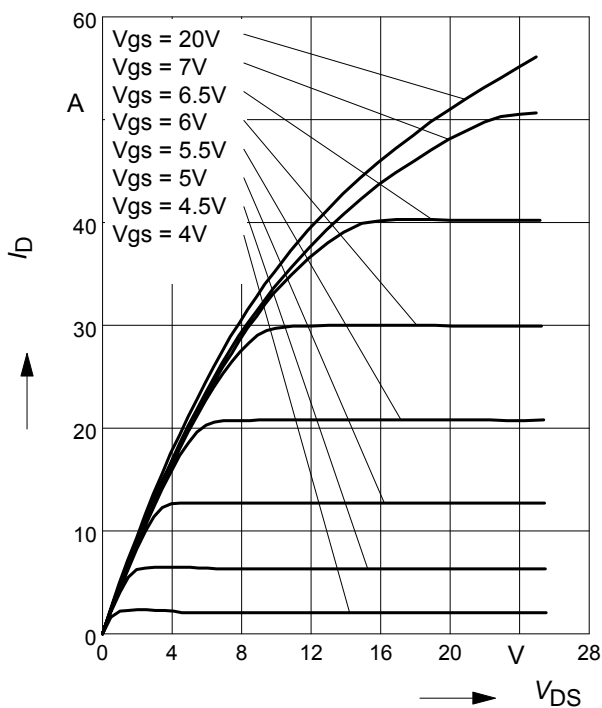
parameter:  $D = t_p/t$



### 7 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

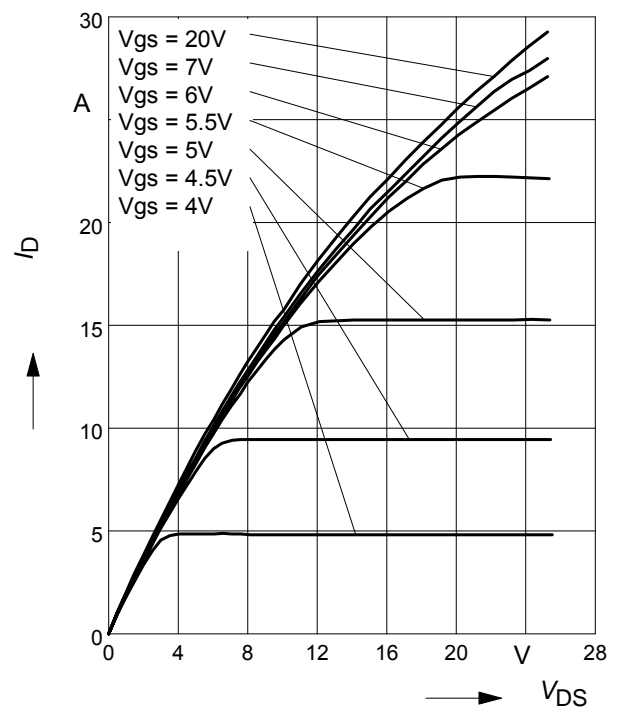
parameter:  $t_p = 10 \mu\text{s}, V_{GS}$



### 8 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 150^\circ\text{C}$$

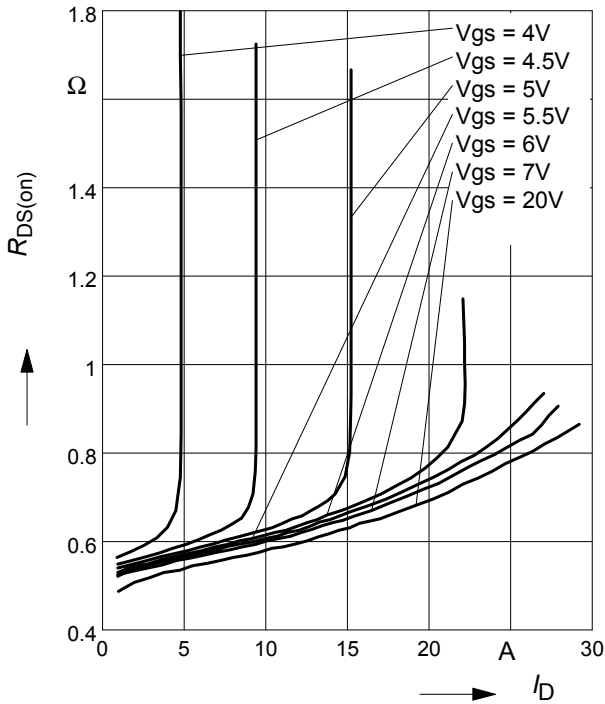
parameter:  $t_p = 10 \mu\text{s}, V_{GS}$



**9 Typ. drain-source on resistance**

$$R_{DS(on)} = f(I_D)$$

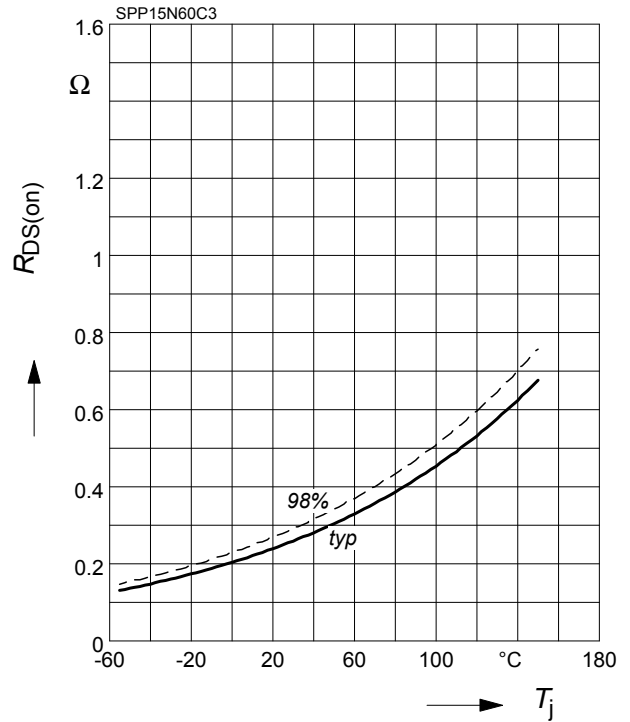
parameter:  $T_j = 150^\circ\text{C}$ ,  $V_{GS}$



**10 Drain-source on-state resistance**

$$R_{DS(on)} = f(T_j)$$

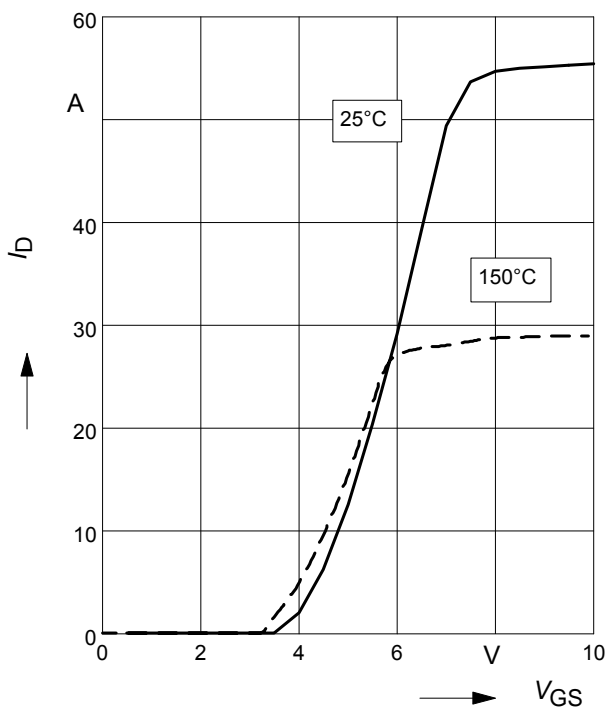
parameter:  $I_D = 9.4 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



**11 Typ. transfer characteristics**

$$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$$

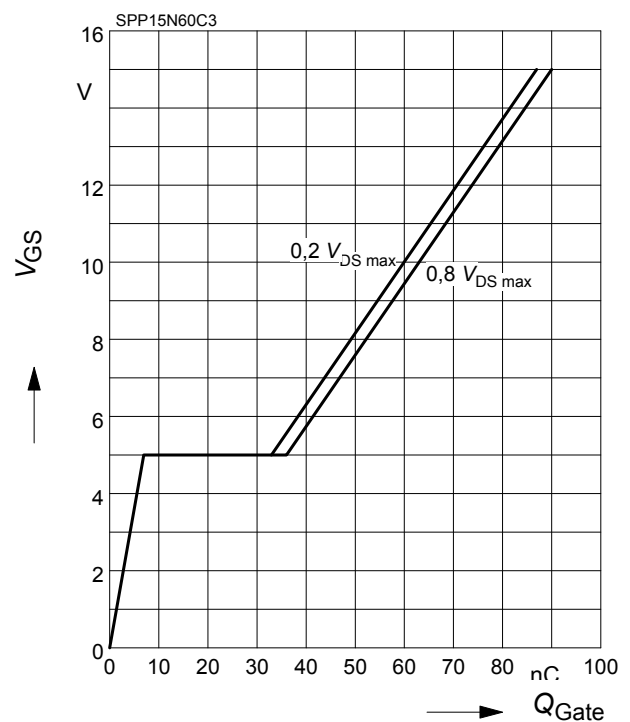
parameter:  $t_p = 10 \mu\text{s}$



**12 Typ. gate charge**

$$V_{GS} = f(Q_{Gate})$$

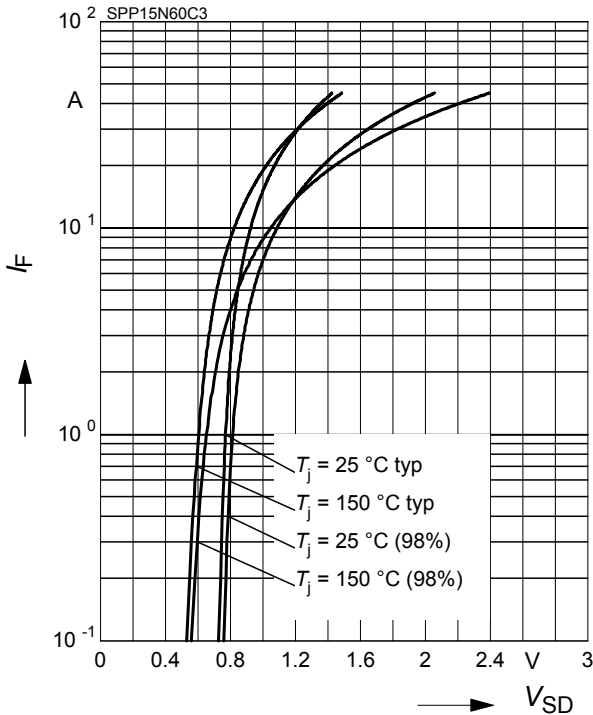
parameter:  $I_D = 15 \text{ A pulsed}$



### 13 Forward characteristics of body diode

$$I_F = f(V_{SD})$$

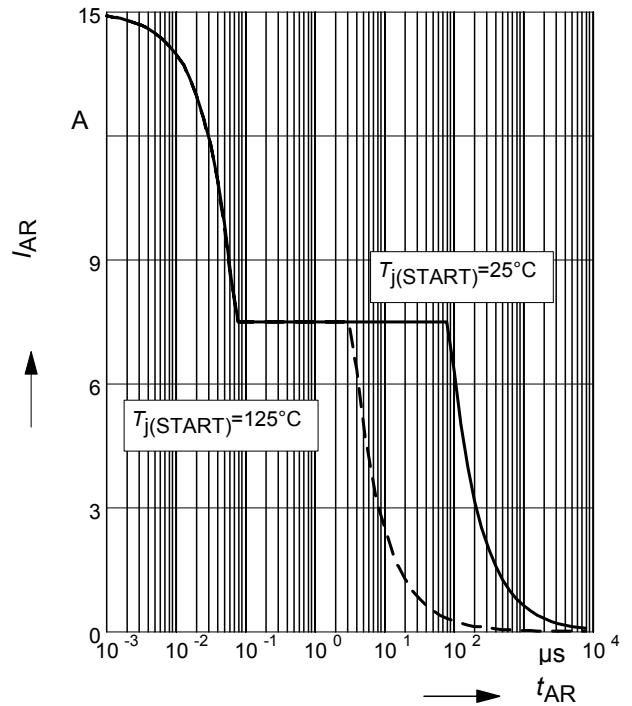
parameter:  $T_j$ ,  $t_p = 10 \mu s$



### 14 Avalanche SOA

$$I_{AR} = f(t_{AR})$$

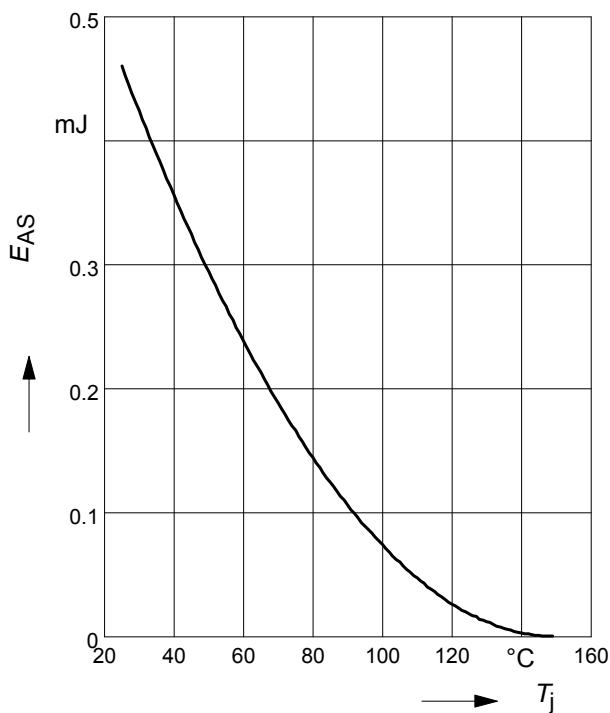
par.:  $T_j \leq 150 \text{ } ^\circ\text{C}$



### 15 Avalanche energy

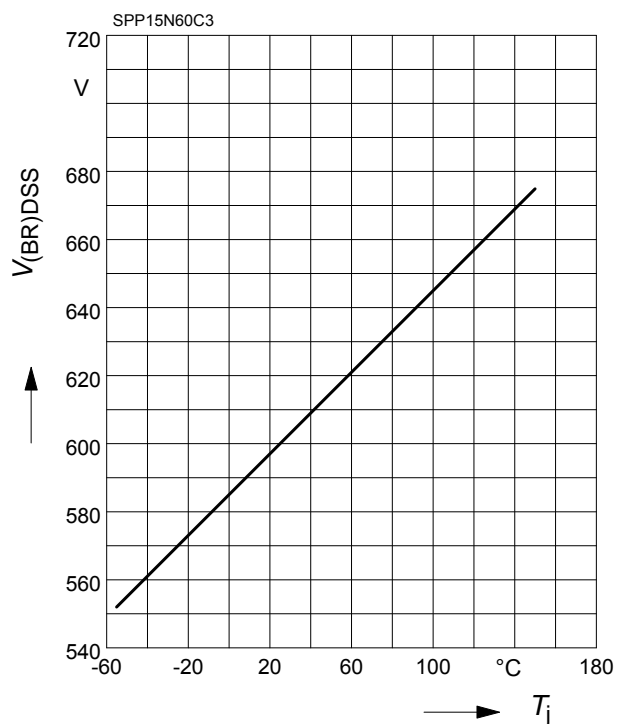
$$E_{AS} = f(T_j)$$

par.:  $I_D = 7.5 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$



### 16 Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$

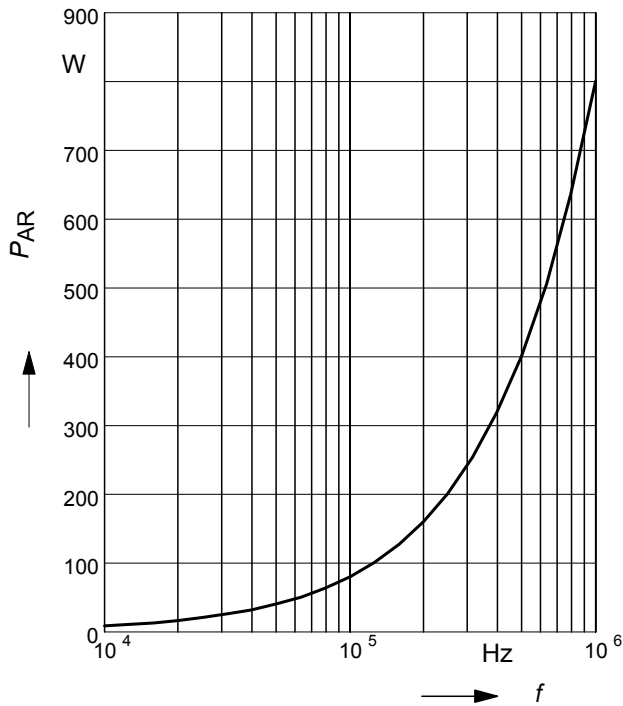




### 17 Avalanche power losses

$$P_{AR} = f(f)$$

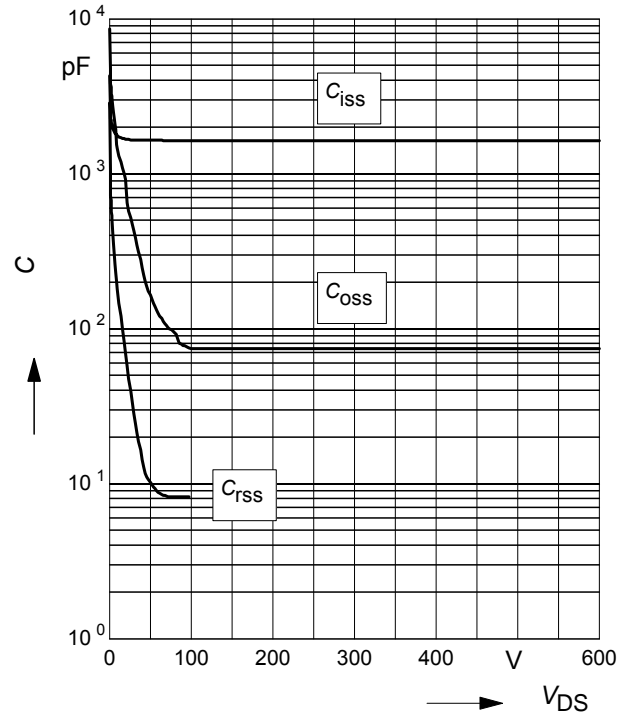
parameter:  $E_{AR}=0.8\text{mJ}$



### 18 Typ. capacitances

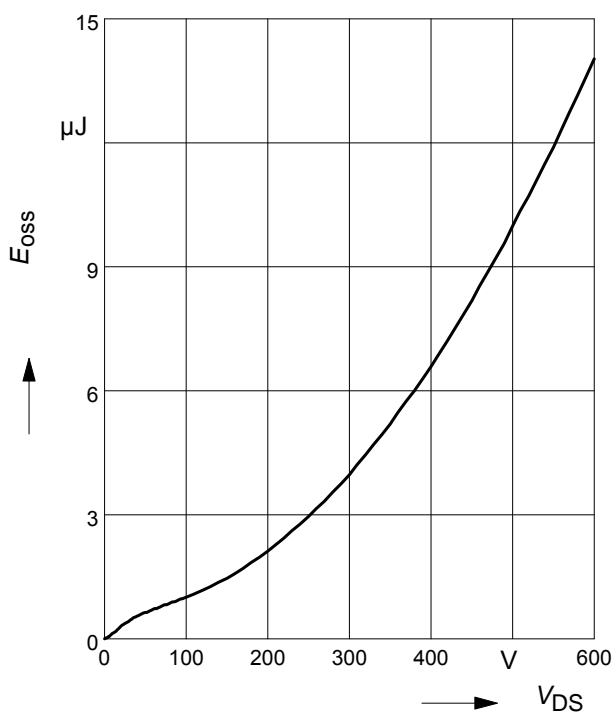
$$C = f(V_{DS})$$

parameter:  $V_{GS}=0\text{V}$ ,  $f=1\text{ MHz}$

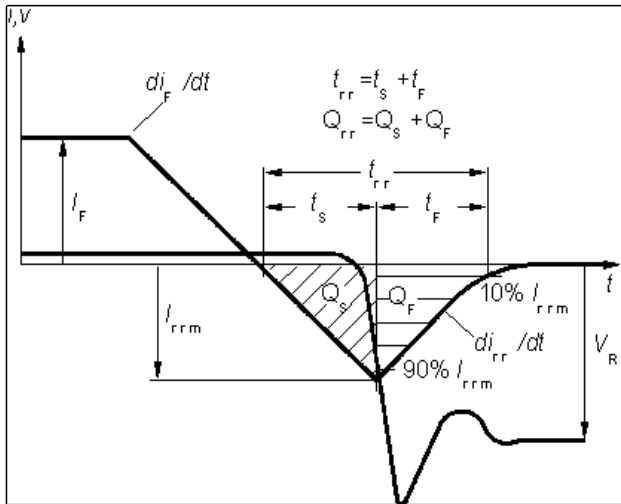


### 19 Typ. $C_{oss}$ stored energy

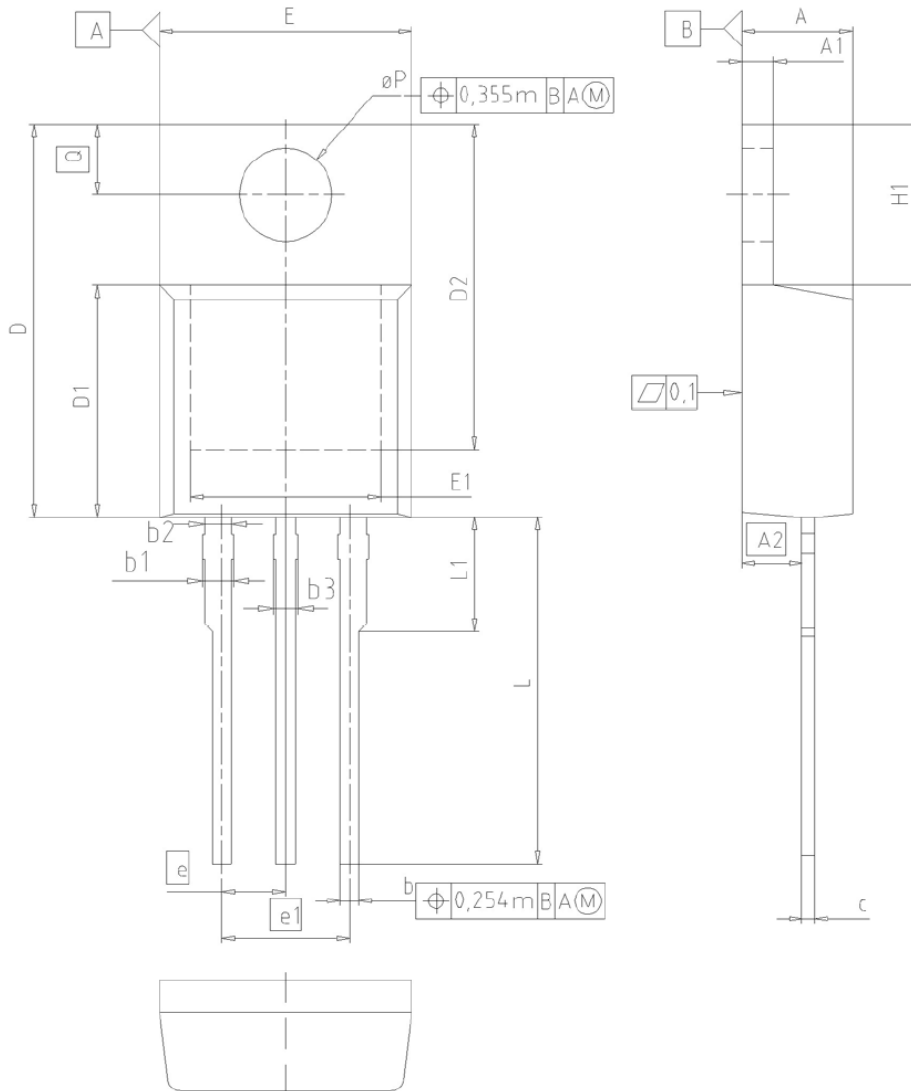
$$E_{oss} = f(V_{DS})$$



Definition of diodes switching characteristics



PG-TO220-3-1, PG-TO220-3-21 : Outline



| DIM      | MILLIMETERS |       | INCHES |       |
|----------|-------------|-------|--------|-------|
|          | MIN         | MAX   | MIN    | MAX   |
| A        | 4.30        | 4.57  | 0.169  | 0.180 |
| A1       | 1.17        | 1.40  | 0.046  | 0.055 |
| A2       | 2.15        | 2.72  | 0.085  | 0.107 |
| b        | 0.65        | 0.86  | 0.026  | 0.034 |
| b1       | 0.95        | 1.40  | 0.037  | 0.055 |
| b2       | 0.95        | 1.15  | 0.037  | 0.045 |
| b3       | 0.65        | 1.15  | 0.026  | 0.045 |
| c        | 0.33        | 0.60  | 0.013  | 0.024 |
| D        | 14.81       | 15.95 | 0.583  | 0.628 |
| D1       | 8.51        | 9.45  | 0.335  | 0.372 |
| D2       | 12.19       | 13.10 | 0.480  | 0.516 |
| E        | 9.70        | 10.36 | 0.382  | 0.408 |
| E1       | 6.50        | 8.60  | 0.256  | 0.339 |
| e        | 2.54        |       | 0.100  |       |
| e1       | 5.08        |       | 0.200  |       |
| N        | 3           |       | 3      |       |
| H1       | 5.90        | 6.90  | 0.232  | 0.272 |
| L        | 13.00       | 14.00 | 0.512  | 0.551 |
| L1       | -           | 4.80  | -      | 0.189 |
| $\phi P$ | 3.60        | 3.89  | 0.142  | 0.153 |
| Q        | 2.60        | 3.00  | 0.102  | 0.118 |

DOCUMENT NO.  
Z8B00003318

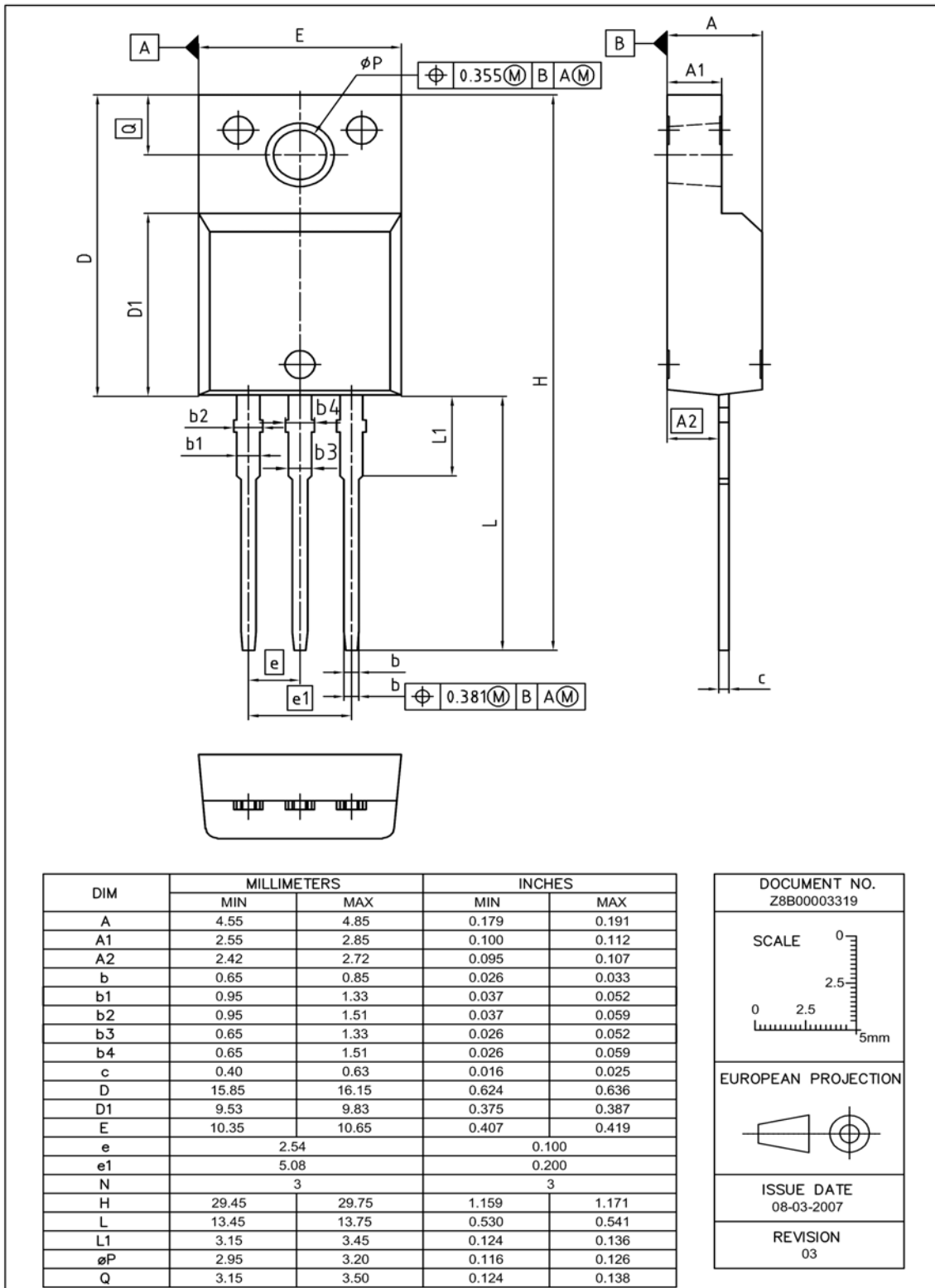
SCALE

EUROPEAN PROJECTION

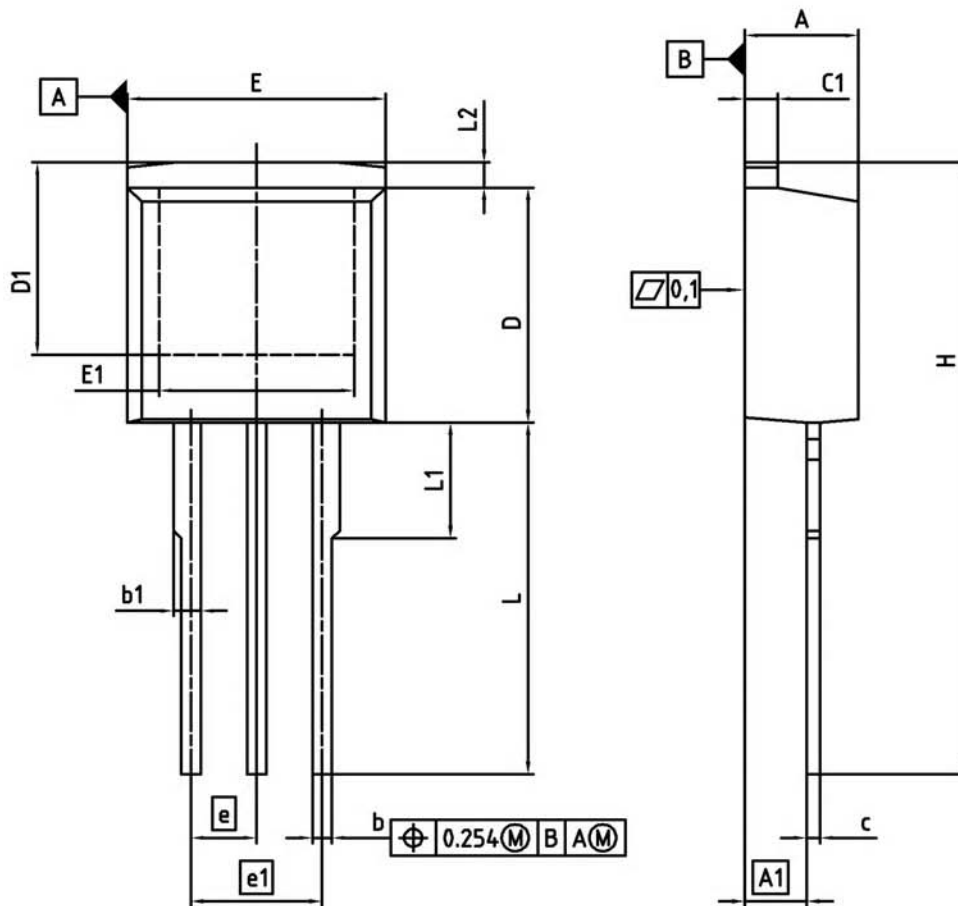
ISSUE DATE  
23-08-2007

REVISION  
05

PG-TO220-3 (Fully isolated)



Dimensions in mm/ inches



| DIM | MILLIMETERS |        | INCHES |       |
|-----|-------------|--------|--------|-------|
|     | MIN         | MAX    | MIN    | MAX   |
| A   | 4.300       | 4.572  | 0.169  | 0.180 |
| A1  | 2.150       | 2.718  | 0.085  | 0.107 |
| b   | 0.650       | 0.864  | 0.026  | 0.034 |
| b1  | 0.635       | 1.400  | 0.025  | 0.055 |
| c   | 0.330       | 0.600  | 0.013  | 0.024 |
| c1  | 1.170       | 1.400  | 0.046  | 0.055 |
| D   | 8.509       | 9.450  | 0.335  | 0.372 |
| D1  | 6.900       | -      | 0.272  | -     |
| E   | 9.700       | 10.363 | 0.382  | 0.408 |
| E1  | 6.500       | 8.600  | 0.256  | 0.339 |
| e   | 2.540       |        | 0.100  |       |
| e1  | 5.080       |        | 0.200  |       |
| N   | 3           |        | 3      |       |
| L   | 13.000      | 14.000 | 0.512  | 0.551 |
| L1  | -           | 4.800  | -      | 0.189 |
| L2  | -           | 1.727  | -      | 0.068 |

REFERENCE  
JEDEC TO262

EUROPEAN PROJECTION

ISSUE DATE  
05-05-2006

FILE  
TO262\_1

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